

CHIP COIL (CHIP INDUCTORS) LQM21DN□□□□00□ REFERENCE SPECIFICATION
1. Scope

This reference specification applies to LQM21DN series, Chip coil (Chip Inductors).

2. Part Numbering

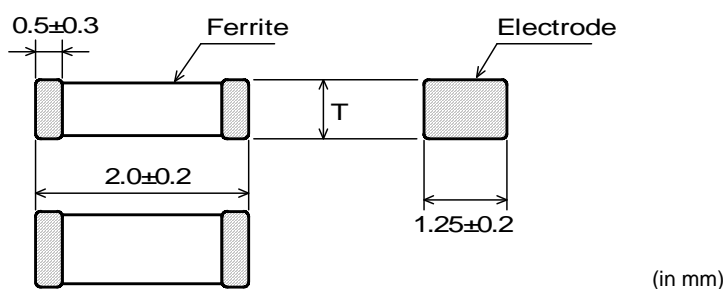
(ex)	LQ	M	21	D	N	1R0	N	0	0	D	
	Product ID	Structure	Dimension (L×W)	Applications and Characteristics	Category	Inductance	Tolerance	Features	Electrode	Packaging	
										D: Taping (Paper tape) L: Taping (Plastic tape) *B: Bulk	

*B: Bulk packing also available

3. Rating

- Operating Temperature Range – 40°C to + 85°C
- Storage Temperature Range – 55°C to +125°C

Customer Part Number	MURATA Part Number	Inductance		DC Resistance (Ω max.)	Self Resonant Frequency (MHz min.)	Rated Current (mA)
		(μH)	Tolerance			
	LQM21DN1R0N00D	1.0	±30%	0.10	75	60
	LQM21DN2R2N00D	2.2		0.17	50	40
	LQM21DN4R7N00D	4.7		0.30	35	30
	LQM21DN100N00D	10		0.50	24	15
	LQM21DN220N00L	22		0.65	16	13
	LQM21DN470N00L	47		1.20	7.5	7

4. Appearance and Dimensions


Dimension of T	Inductance: 1.0μH to 10μH	0.85mm±0.2mm
		Inductance: 22μH to 47μH

Unit Mass (Typical value)	Inductance: 1.0μH to 10μH	0.010g
		Inductance: 22μH to 47μH

5. Testing Conditions

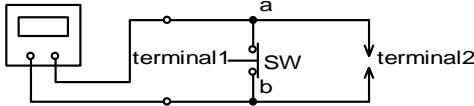
«Unless otherwise specified»

Temperature : Ordinary Temperature / 15°C to 35°C
 Humidity : Ordinary Humidity / 25%(RH) to 85%(RH)

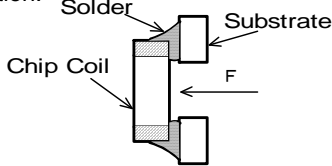
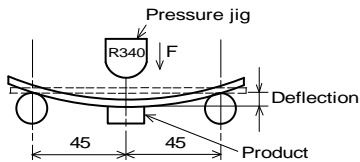
«In case of doubt»

Temperature : 20°C ± 2°C
 Humidity : 60%(RH) to 70%(RH)
 Atmospheric Pressure : 86kPa to 106kPa

6. Electrical Performance

No.	Item	Specification	Test Method
6.1	Inductance	Inductance shall meet item 3.	Measuring Equipment: Agilent 4291A or equivalent (1mA) Measuring Frequency: 1MHz
6.2	DC Resistance	DC Resistance shall meet item 3.	Measuring Equipment: Digital multi meter Digital multi meter (TR6846 or equivalent)  DC resistance shall be measured after putting chip coil between the terminal 2 under the condition of opening between a and b. Every measurement the terminal 1 shall be shorted between a and b when changing chip coil.
6.3	Self Resonant Frequency (S.R.F)	S.R.F shall meet item 3.	Measuring Equipment: Agilent 4195A or equivalent (1mA)
6.4	Rated Current	Self temperature rise shall be limited to 20°C max. Inductance Change: within $\pm 50\%$	The rated current is applied.

7. Mechanical Performance

No.	Item	Specification	Test Method
7.1	Shear Test	Chip coil shall not be damaged after tested as test method.	Applied Direction:  Force: 10N Hold Duration: 5 s \pm 1 s
7.2	Bending Test	Chip coil shall not be damaged after tested as test method.	Substrate: Glass-epoxy substrate (100mm \times 40mm \times 1.6mm)  Speed of Applying Force: 1mm / s Deflection: 2mm Hold Duration: 30s (in mm)
7.3	Vibration	Chip coil shall not be damaged after tested as test method.	Oscillation Frequency: 10Hz to 55Hz to 10Hz for 1 min Total Amplitude: 1.5mm Testing Time: A period of 2 h in each of 3 mutually Perpendicular directions.
7.4	Solderability	The wetting area of the electrode shall be at least 90% covered with new solder coating.	Flux: Ethanol solution of rosin 25(wt)% (Immersed for 5s to 10s) Solder: Sn-3.0Ag-0.5Cu Pre-Heating: 150°C \pm 10°C / 60s to 90s Solder Temperature: 240°C \pm 5°C Immersion Time: 3s \pm 1s
7.5	Resistance to Soldering Heat	Appearance: No damage Inductance Change: within $\pm 20\%$	Flux: Ethanol solution of rosin 25(wt)% (Immersed for 5s to 10s) Solder: Sn-3.0Ag-0.5Cu Pre-Heating: 150°C \pm 10°C / 60s to 90s Solder Temperature: 270°C \pm 5°C Immersion Time: 10s \pm 1s Then measured after exposure in the room condition for 24h \pm 2h.

8. Environmental Performance

It shall be soldered on the substrate.

No.	Item	Specification	Test Method
8.1	Heat Resistance	Appearance: No damage Inductance Change: within $\pm 20\%$	Temperature: $85^{\circ}\text{C} \pm 2^{\circ}\text{C}$ Time: 1000 h (+48h, -0h) Then measured after exposure in the room condition for $48\text{h} \pm 2\text{h}$.
8.2	Cold Resistance		Temperature: $-40^{\circ}\text{C} \pm 2^{\circ}\text{C}$ Time: 1000 h (+48h, -0h) Then measured after exposure in the room condition for $48\text{h} \pm 2\text{h}$.
8.3	Humidity		Temperature: $40^{\circ}\text{C} \pm 2^{\circ}\text{C}$ Humidity: 90%(RH) to 95%(RH) Time: 1000 h (+48h, -0h) Then measured after exposure in the room condition for $48\text{h} \pm 2\text{h}$.
8.4	Temperature Cycle		1 cycle: 1 step: $-40^{\circ}\text{C} \pm 2^{\circ}\text{C}$ / 30 min \pm 3 min 2 step: Ordinary temp. / 10 min to 15 min 3 step: $+85^{\circ}\text{C} \pm 2^{\circ}\text{C}$ / 30 min \pm 3 min 4 step: Ordinary temp. / 10 min to 15 min Total of 10 cycles Then measured after exposure in the room condition for $48\text{h} \pm 2\text{h}$.

9. Specification of Packaging

9.1 Appearance and Dimensions of paper tape, plastic tape (8mm-wide)

P/N	Type	Dimensions (in mm)
LQM21D 1R0N00D 2R2N00D 4R7N00D 100N00D	8mm-wide Paper tape	
LQM21D 220N00L 470N00L	8mm-wide Plastic tape	<p>• Dimension of the Cavity is measured at the bottom side.</p>

9.2 Specification of Taping

- (1) Packing quantity (standard quantity)
 - Inductance : 1.0μH to 10μH (Paper tape) 4,000 pcs / reel
 - Inductance : 22μH to 47 μH (Plastic tape) 3,000 pcs / reel
- (2) Packing Method
 - (Paper tape)
Products shall be packed in the cavity of the base tape and sealed by top tape and bottom tape.
 - (Plastic tape)
Products shall be packed in the each embossed cavity of plastic tape and sealed by cover tape.
- (3) Sprocket hole
The sprocket holes are to the right as the tape is pulled toward the user.
- (4) Spliced point
 - (Paper tape)
Base tape and Top tape has no spliced point.
 - (Plastic tape)
Plastic tape and Cover tape has no spliced point.
- (5) Missing components number
Missing components number within 0.1% of the number per reel or 1 pc., whichever is greater, and are not continuous. The Specified quantity per reel is kept.

9.3 Pull Strength

【Case of Paper tape】

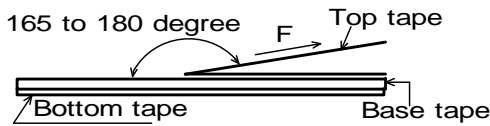
Top tape	5N min.
Bottom tape	

【Case of Plastic tape】

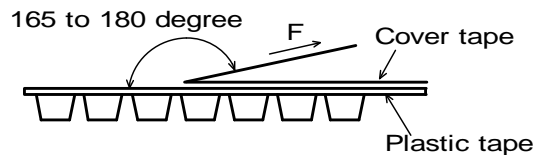
Plastic tape	10N min.
Cover tape	5N min.

9.4 Peeling off force

【Case of Paper tape】



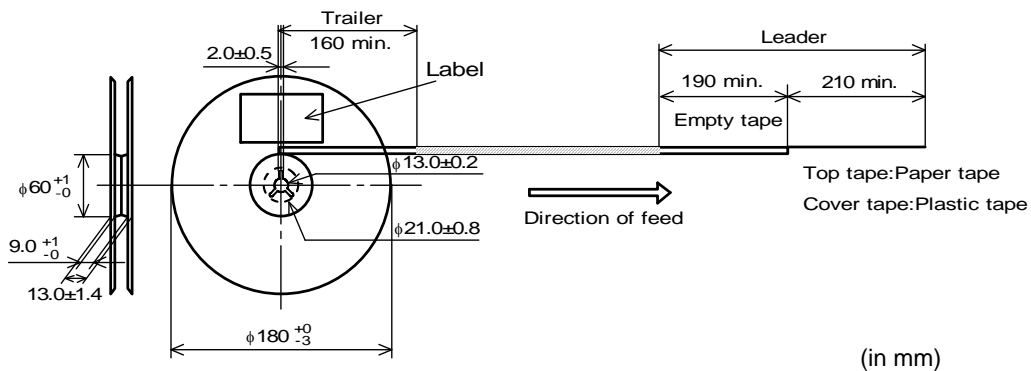
【Case of Plastic tape】



Speed of Peeling off	300mm / min
Peeling off force	Paper tape: 0.1N to 0.6N Plastic tape: 0.2N to 0.7N (minimum value is typical)

9.5 Dimensions of Leader-tape, Trailer and Reel

There shall be leader-tape (top tape / cover tape and empty tape) and trailer-tape (empty tape) as follows.

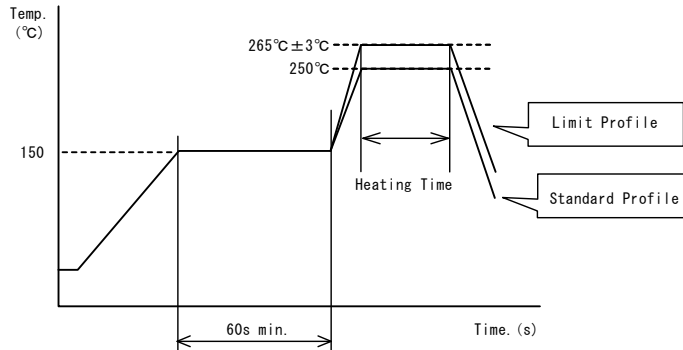


11.3 Flow soldering / Reflow soldering conditions

- Pre-heating should be in such a way that the temperature difference between solder and product surface is limited to 150°C max. Cooling into solvent after soldering also should be in such a way that the temperature difference is limited to 100°C max. Insufficient pre-heating may cause cracks on the product, resulting in the deterioration of products quality.
- Standard soldering profile and the limit soldering profile is as follows.
The excessive limit soldering conditions may cause leaching of the electrode and / or resulting in the deterioration of product quality.

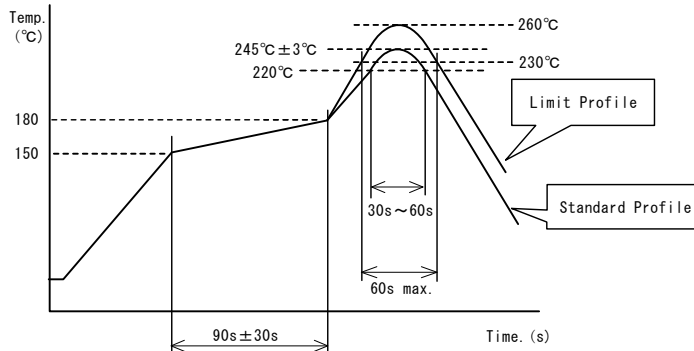
Soldering profile

(1) Flow soldering profile



	Standard Profile	Limit Profile
Pre-heating	150°C, 60s min.	
Heating	250°C, 4s~6s	265°C±3°C, 5s
Cycle of flow	2 times	

(2) Reflow soldering profile



	Standard Profile	Limit Profile
Pre-heating	150°C~180°C, 90s±30s	
Heating	above 220°C, 30s~60s	above 230°C, 60s max.
Peak temperature	245°C±3°C	260°C, 10s
Cycle of reflow	2 times	

11.4 Reworking with soldering iron.

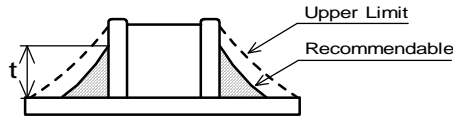
The following conditions must be strictly followed when using a soldering iron.

Pre-heating	150°C, 1 min
Tip temperature	350°C max.
Soldering iron output	80W max.
Tip diameter	φ 3mm max.
Soldering time	3(+1, -0)s
Time	2 times

Note : Do not directly touch the products with the tip of the soldering iron in order to prevent the crack on the products due to the thermal shock.

11.5 Solder Volume

- Solder shall be used not to be exceeded the upper limits as shown below.
- Accordingly increasing the solder volume, the mechanical stress to Chip is also increased. Exceeding solder volume may cause the failure of mechanical or electrical performance.

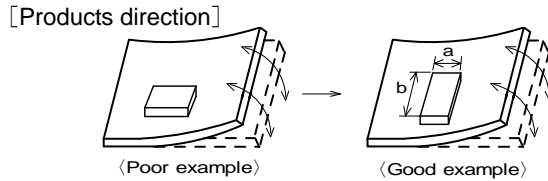


$1/3T \leq t \leq T$
 T : thickness of product

11.6 Product's location

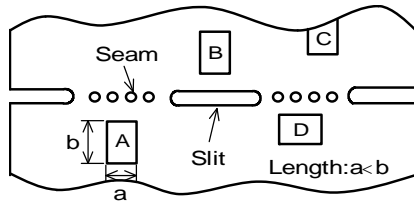
The following shall be considered when designing and laying out P.C.B.'s.

- (1) P.C.B. shall be designed so that products are not subject to the mechanical stress due to warping the board.



Products shall be located in the sideways direction (Length: $a < b$) to the mechanical stress.

- (2) Products location on P.C.B. separation



Products (A, B, C, D) shall be located carefully so that products are not subject to the mechanical stress due to warping the board. Because they may be subjected the mechanical stress in order of $A \cdot C \cdot B \cong D$.

11.7 Cleaning Conditions

Products shall be cleaned on the following conditions.

- (1) Cleaning temperature shall be limited to 60°C max. (40°C max for IPA.)
- (2) Ultrasonic cleaning shall comply with the following conditions with avoiding the resonance phenomenon at the mounted products and P.C.B.
 Power : 20 W / l max. Frequency : 28kHz to 40kHz Time : 5 min max.
- (3) Cleaner
 1. Alcohol type cleaner
Isopropyl alcohol (IPA)
 2. Aqueous agent
PINE ALPHA ST-100S
- (4) There shall be no residual flux and residual cleaner after cleaning. In the case of using aqueous agent, products shall be dried completely after rinse with de-ionized water in order to remove the cleaner.
- (5) Other cleaning Please contact us.

11.8 Resin coating

The inductance value may change and/or it may affect on the product's performance due to high cure-stress of resin to be used for coating/molding products. So please pay your careful attention when you select resin.
 In prior to use, please make the reliability evaluation with the product mounted in your application set.

11.9 Caution for use

There is possibility that the inductance value change due to magnetism. Don't use a magnet or a pair of tweezers with magnetism when chip coil are handled. (The tip of the tweezers should be molded with resin or pottery.)

11.10 Magnetic Saturation

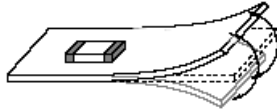
When the excessive current over rated current is applied, the inductance value may change due to magnetism.

11.11 Handling of a substrate

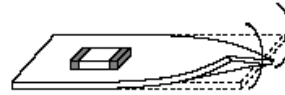
After mounting products on a substrate, do not apply any stress to the product caused by bending or twisting to the substrate when cropping the substrate, inserting and removing a connector from the substrate or tightening screw to the substrate.

Excessive mechanical stress may cause cracking in the product.

Bending



Twisting



11.12 Storage and Handling Requirements

(1) Storage period

Use the products within 6 months after delivered.
Solderability should be checked if this period is exceeded.

(2) Storage conditions

- Products should be stored in the warehouse on the following conditions.
 - Temperature : -10°C to 40°C
 - Humidity : 15% to 85% relative humidity No rapid change on temperature and humidity
- Don't keep products in corrosive gases such as sulfur, chlorine gas or acid, or it may cause oxidization of electrode, resulting in poor solderability.
- Products should be stored on the palette for the prevention of the influence from humidity, dust and so on.
- Products should be stored in the warehouse without heat shock, vibration, direct sunlight and so on.
- Products should be stored under the airtight packaged condition.

(3) Handling Condition

Care should be taken when transporting or handling product to avoid excessive vibration or mechanical shock.

12. Note

- (1) Please make sure that your product has been evaluated in view of your specifications with our product being mounted to your product.
- (2) You are requested not to use our product deviating from the reference specifications.
- (3) The contents of this reference specification are subject to change without advance notice.
Please approve our product specifications or transact the approval sheet for product specifications before ordering.